

MOSFET

StrongIRFET™2 Power-Transistor, 40 V

Features

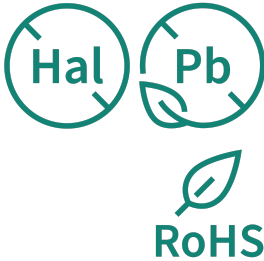
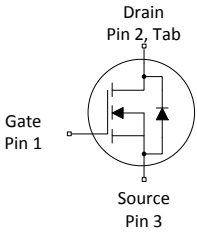
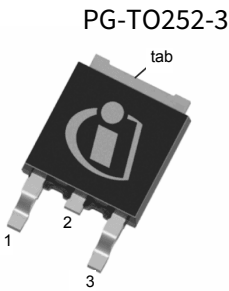
- Optimized for wide range of applications
- N-channel, normal level
- 100% avalanche tested
- Pb-free lead plating; RoHS compliant
- Halogen-free according to IEC61249-2-21

Product validation

Qualified according to JEDEC Standard

Table 1 Key Performance Parameters

Parameter	Value	Unit
$V_{DS}$	40	V
$R_{DS(on),max}$	2.3	mΩ
$I_D$	143	A
$Q_{oss}$	76	nC
$Q_G(0V..10V)$	68	nC



Type/Ordering Code	Package	Marking	Related Links
IPD023N04NF2S	PG-T0252-3	023N04NS	-



Table of Contents

Description ..... 1

Maximum ratings ..... 3

Thermal characteristics ..... 4

Electrical characteristics ..... 5

Electrical characteristics diagrams ..... 7

Package Outlines ..... 11

Revision History ..... 13

Trademarks ..... 13

Disclaimer ..... 13

## 1 Maximum ratings

at  $T_A=25\text{ °C}$ , unless otherwise specified

**Table 2 Maximum ratings**

Parameter	Symbol	Values			Unit	Note/ Test Condition
		Min.	Typ.	Max.		
Continuous drain current <sup>1)</sup>	$I_D$	-	-	143 110 27	A	$V_{GS}=10\text{ V}$ , $T_C=25\text{ °C}$ $V_{GS}=10\text{ V}$ , $T_C=100\text{ °C}$ $V_{GS}=10\text{ V}$ , $T_A=25\text{ °C}$ , $R_{THJA}=50\text{ °C/W}$ <sup>2)</sup>
Pulsed drain current <sup>3)</sup>	$I_{D,pulse}$	-	-	572	A	$T_A=25\text{ °C}$
Avalanche energy, single pulse <sup>4)</sup>	$E_{AS}$	-	-	167	mJ	$I_D=70\text{ A}$ , $R_{GS}=25\text{ }\Omega$
Gate source voltage	$V_{GS}$	-20	-	20	V	-
Power dissipation	$P_{tot}$	-	-	150 3.0	W	$T_C=25\text{ °C}$ $T_A=25\text{ °C}$ , $R_{THJA}=50\text{ °C/W}$ <sup>2)</sup>
Operating and storage temperature	$T_j, T_{stg}$	-55	-	175	°C	-

<sup>1)</sup> Rating refers to the product only with datasheet specified absolute maximum values, maintaining case temperature as specified. For other case temperatures please refer to Diagram 2. De-rating will be required based on the actual environmental conditions.

<sup>2)</sup> Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm<sup>2</sup> (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

<sup>3)</sup> See Diagram 3 for more detailed information

<sup>4)</sup> See Diagram 13 for more detailed information

## 2 Thermal characteristics

**Table 3 Thermal characteristics**

Parameter	Symbol	Values			Unit	Note/ Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction - case	$R_{thJC}$	-	-	1.0	°C/W	-
Thermal resistance, junction - ambient, 6 cm <sup>2</sup> cooling area <sup>5)</sup>	$R_{thJA}$	-	-	50	°C/W	-
Thermal resistance, junction - ambient, minimal footprint	$R_{thJA}$	-	-	75	°C/W	-

<sup>5)</sup> Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm<sup>2</sup> (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

### 3 Electrical characteristics

at  $T_j=25\text{ °C}$ , unless otherwise specified

**Table 4 Static characteristics**

Parameter	Symbol	Values			Unit	Note/ Test Condition
		Min.	Typ.	Max.		
Drain-source breakdown voltage	$V_{(BR)DSS}$	40	-	-	V	$V_{GS}=0\text{ V}$ , $I_D=1\text{ mA}$
Gate threshold voltage	$V_{GS(th)}$	2.2	2.8	3.4	V	$V_{DS}=V_{GS}$ , $I_D=81\text{ }\mu\text{A}$
Zero gate voltage drain current	$I_{DSS}$	-	0.1 10	1 100	$\mu\text{A}$	$V_{DS}=40\text{ V}$ , $V_{GS}=0\text{ V}$ , $T_j=25\text{ °C}$ $V_{DS}=40\text{ V}$ , $V_{GS}=0\text{ V}$ , $T_j=125\text{ °C}$
Gate-source leakage current	$I_{GSS}$	-	10	100	nA	$V_{GS}=20\text{ V}$ , $V_{DS}=0\text{ V}$
Drain-source on-state resistance	$R_{DS(on)}$	-	1.9 2.2	2.3 3.1	m $\Omega$	$V_{GS}=10\text{ V}$ , $I_D=70\text{ A}$ $V_{GS}=6\text{ V}$ , $I_D=35\text{ A}$
Gate resistance	$R_G$	-	3.0	-	$\Omega$	-
Transconductance <sup>6)</sup>	$g_{fs}$	125	-	-	S	$ V_{DS} \geq 2 I_D R_{DS(on)max}$ , $I_D=70\text{ A}$

<sup>6)</sup> Defined by design. Not subject to production test.

**Table 5 Dynamic characteristics**

Parameter	Symbol	Values			Unit	Note/ Test Condition
		Min.	Typ.	Max.		
Input capacitance	$C_{iss}$	-	4800	-	pF	$V_{GS}=0\text{ V}$ , $V_{DS}=20\text{ V}$ , $f=1\text{ MHz}$
Output capacitance	$C_{oss}$	-	1780	-	pF	$V_{GS}=0\text{ V}$ , $V_{DS}=20\text{ V}$ , $f=1\text{ MHz}$
Reverse transfer capacitance	$C_{rss}$	-	98	-	pF	$V_{GS}=0\text{ V}$ , $V_{DS}=20\text{ V}$ , $f=1\text{ MHz}$
Turn-on delay time	$t_{d(on)}$	-	16	-	ns	$V_{DD}=20\text{ V}$ , $V_{GS}=10\text{ V}$ , $I_D=70\text{ A}$ , $R_{G,ext}=1.6\text{ }\Omega$
Rise time	$t_r$	-	15	-	ns	$V_{DD}=20\text{ V}$ , $V_{GS}=10\text{ V}$ , $I_D=70\text{ A}$ , $R_{G,ext}=1.6\text{ }\Omega$
Turn-off delay time	$t_{d(off)}$	-	35	-	ns	$V_{DD}=20\text{ V}$ , $V_{GS}=10\text{ V}$ , $I_D=70\text{ A}$ , $R_{G,ext}=1.6\text{ }\Omega$
Fall time	$t_f$	-	15	-	ns	$V_{DD}=20\text{ V}$ , $V_{GS}=10\text{ V}$ , $I_D=70\text{ A}$ , $R_{G,ext}=1.6\text{ }\Omega$

**Table 6 Gate charge characteristics <sup>7)</sup>**

Parameter	Symbol	Values			Unit	Note/ Test Condition
		Min.	Typ.	Max.		
Gate to source charge	$Q_{gs}$	-	21	-	nC	$V_{DD}=20\text{ V}$ , $I_D=70\text{ A}$ , $V_{GS}=0\text{ to }10\text{ V}$
Gate charge at threshold	$Q_{g(th)}$	-	14	-	nC	$V_{DD}=20\text{ V}$ , $I_D=70\text{ A}$ , $V_{GS}=0\text{ to }10\text{ V}$
Gate to drain charge	$Q_{gd}$	-	13	-	nC	$V_{DD}=20\text{ V}$ , $I_D=70\text{ A}$ , $V_{GS}=0\text{ to }10\text{ V}$
Switching charge	$Q_{sw}$	-	20	-	nC	$V_{DD}=20\text{ V}$ , $I_D=70\text{ A}$ , $V_{GS}=0\text{ to }10\text{ V}$
Gate charge total <sup>8)</sup>	$Q_g$	-	68	102	nC	$V_{DD}=20\text{ V}$ , $I_D=70\text{ A}$ , $V_{GS}=0\text{ to }10\text{ V}$

**Table 6 Gate charge characteristics** <sup>7)</sup>

Parameter	Symbol	Values			Unit	Note/ Test Condition
		Min.	Typ.	Max.		
Gate plateau voltage	$V_{\text{plateau}}$	-	4.3	-	V	$V_{\text{DD}}=20\text{ V}$ , $I_{\text{D}}=70\text{ A}$ , $V_{\text{GS}}=0\text{ to }10\text{ V}$
Gate charge total, sync. FET	$Q_{\text{g(sync)}}$	-	61	-	nC	$V_{\text{DS}}=0.1\text{ V}$ , $V_{\text{GS}}=0\text{ to }10\text{ V}$
Output charge	$Q_{\text{oss}}$	-	76	-	nC	$V_{\text{DS}}=20\text{ V}$ , $V_{\text{GS}}=0\text{ V}$

<sup>7)</sup> See "Gate charge waveforms" for parameter definition

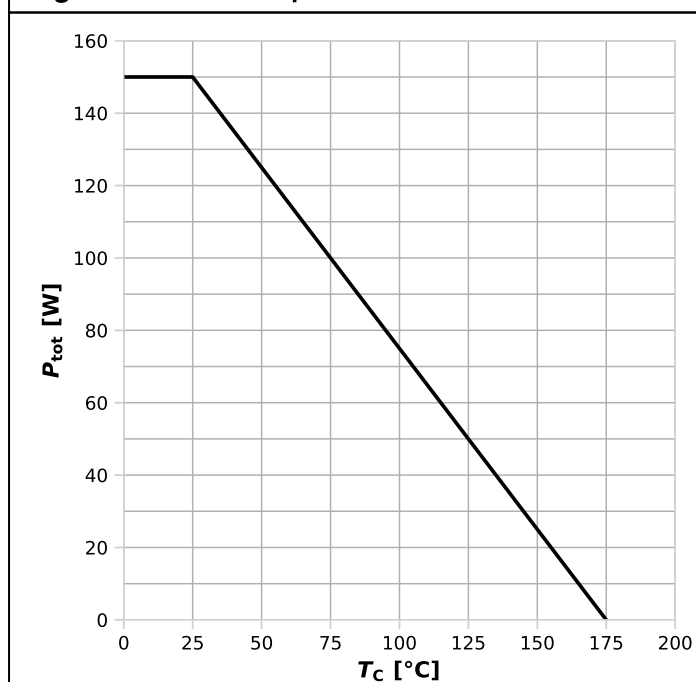
<sup>8)</sup> Defined by design. Not subject to production test.

**Table 7 Reverse diode**

Parameter	Symbol	Values			Unit	Note/ Test Condition
		Min.	Typ.	Max.		
Diode continuous forward current	$I_{\text{S}}$	-	-	106	A	$T_{\text{C}}=25\text{ °C}$
Diode pulse current	$I_{\text{S,pulse}}$	-	-	572	A	$T_{\text{C}}=25\text{ °C}$
Diode forward voltage	$V_{\text{SD}}$	-	0.87	1.1	V	$V_{\text{GS}}=0\text{ V}$ , $I_{\text{F}}=70\text{ A}$ , $T_{\text{j}}=25\text{ °C}$
Reverse recovery time	$t_{\text{rr}}$	-	44	-	ns	$V_{\text{R}}=20\text{ V}$ , $I_{\text{F}}=70\text{ A}$ , $di_{\text{F}}/dt=100\text{ A}/\mu\text{s}$
Reverse recovery charge	$Q_{\text{rr}}$	-	45	-	nC	$V_{\text{R}}=20\text{ V}$ , $I_{\text{F}}=70\text{ A}$ , $di_{\text{F}}/dt=100\text{ A}/\mu\text{s}$
Reverse recovery time	$t_{\text{rr}}$	-	32	-	ns	$V_{\text{R}}=20\text{ V}$ , $I_{\text{F}}=70\text{ A}$ , $di_{\text{F}}/dt=500\text{ A}/\mu\text{s}$
Reverse recovery charge	$Q_{\text{rr}}$	-	125	-	nC	$V_{\text{R}}=20\text{ V}$ , $I_{\text{F}}=70\text{ A}$ , $di_{\text{F}}/dt=500\text{ A}/\mu\text{s}$

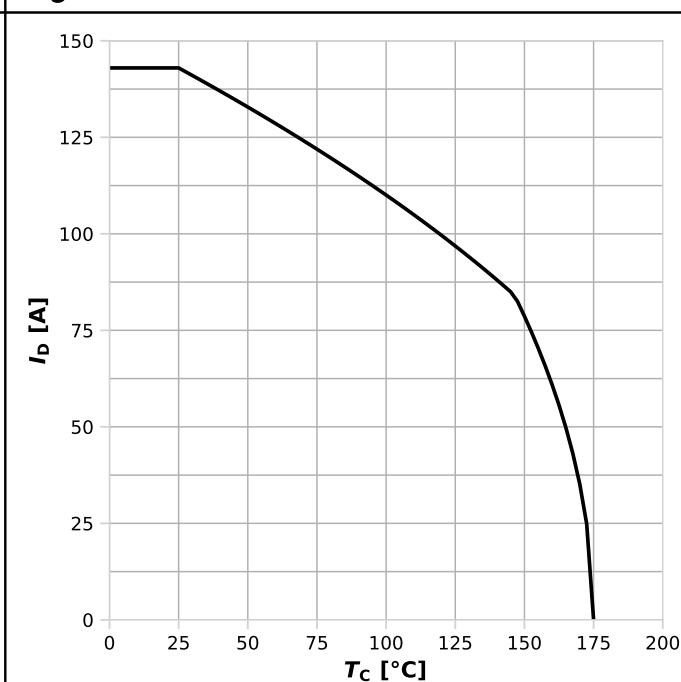
## 4 Electrical characteristics diagrams

Diagram 1: Power dissipation



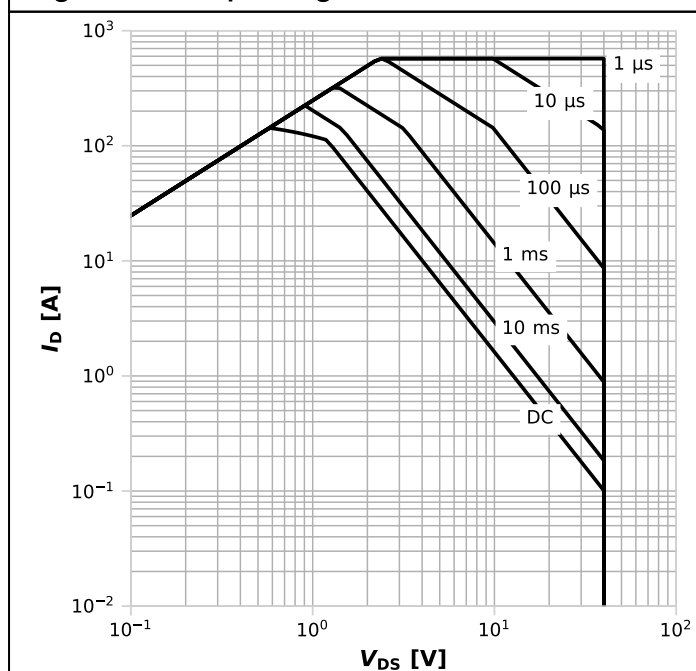
$$P_{tot}=f(T_c)$$

Diagram 2: Drain current



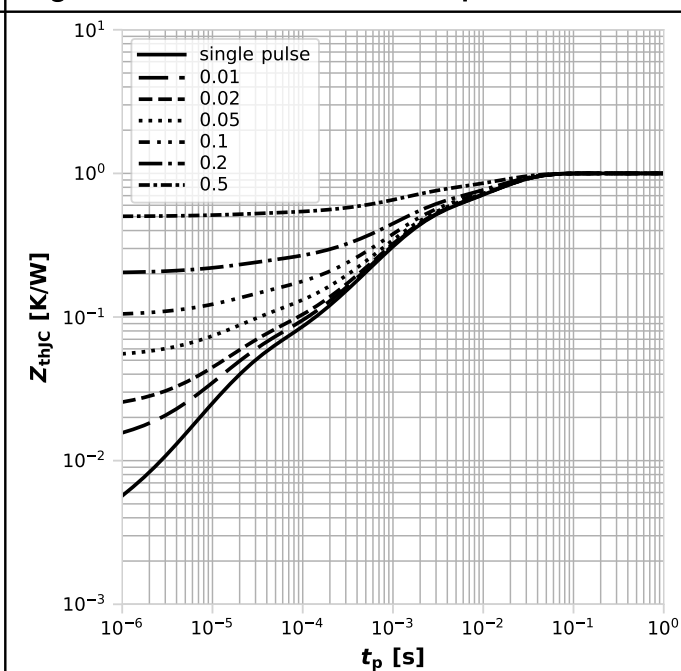
$$I_D=f(T_c); V_{GS} \geq 10 \text{ V}$$

Diagram 3: Safe operating area



$$I_D=f(V_{DS}); T_c=25 \text{ °C}; D=0; \text{parameter: } t_p$$

Diagram 4: Max. transient thermal impedance



$$Z_{thJC}=f(t_p); \text{parameter: } D=t_p/T$$

Diagram 5: Typ. output characteristics

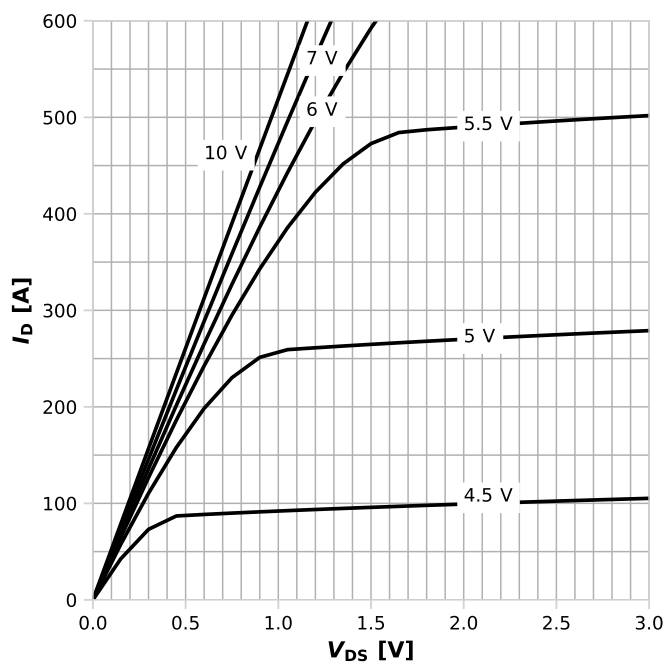

 $I_D = f(V_{DS})$ ,  $T_j = 25^\circ\text{C}$ ; parameter:  $V_{GS}$ 

Diagram 6: Typ. drain-source on resistance

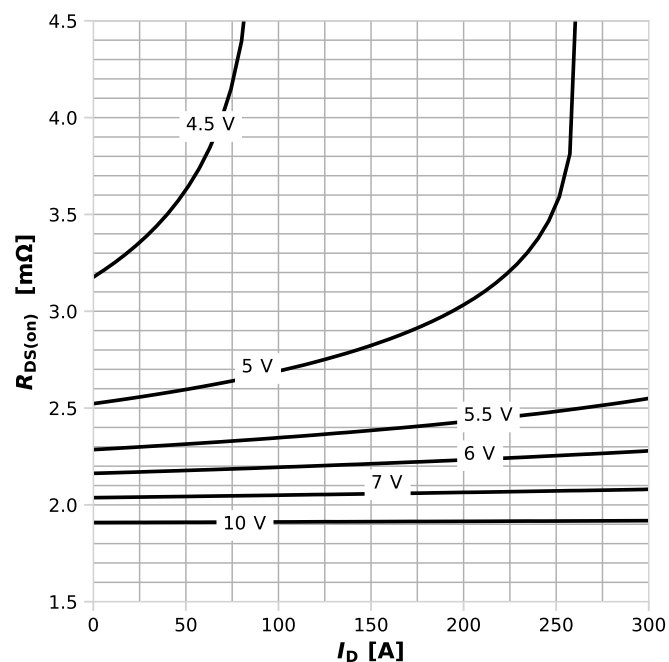

 $R_{DS(on)} = f(I_D)$ ,  $T_j = 25^\circ\text{C}$ ; parameter:  $V_{GS}$ 

Diagram 7: Typ. transfer characteristics

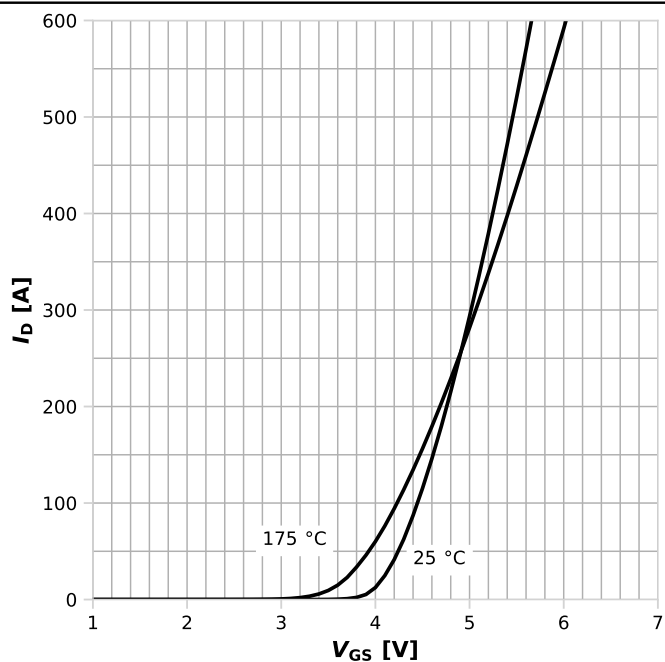

 $I_D = f(V_{GS})$ ,  $|V_{DS}| > 2|I_D|R_{DS(on)max}$ ; parameter:  $T_j$ 

Diagram 8: Typ. drain-source on resistance

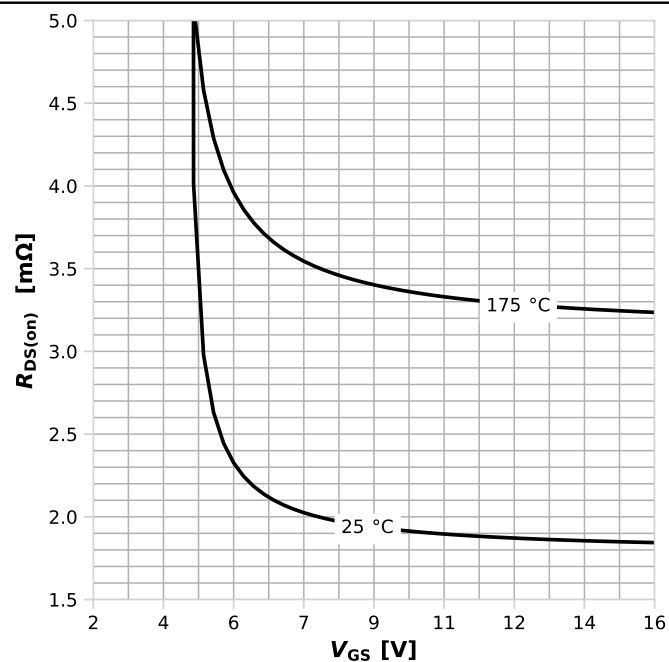
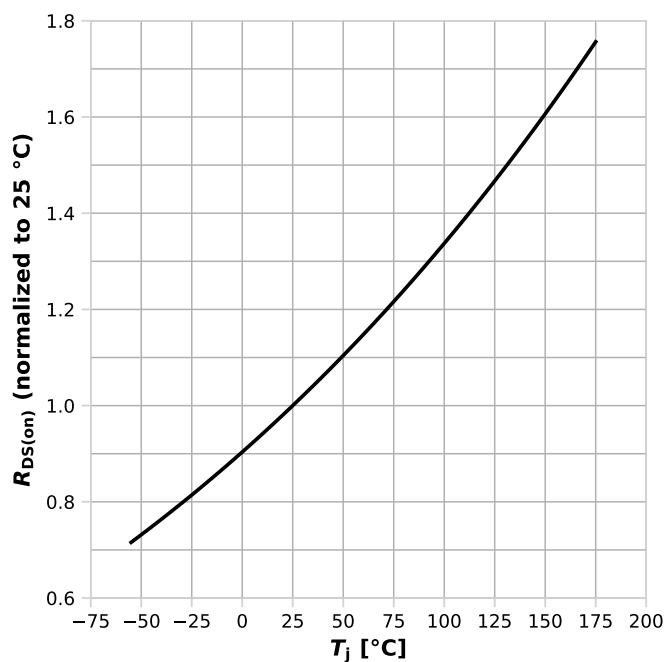

 $R_{DS(on)} = f(V_{GS})$ ,  $I_D = 70\text{ A}$ ; parameter:  $T_j$

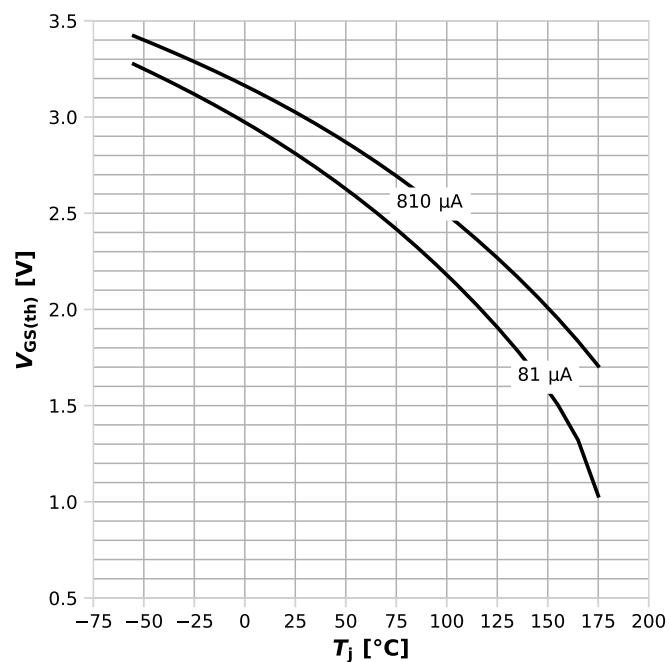


Diagram 9: Normalized drain-source on resistance



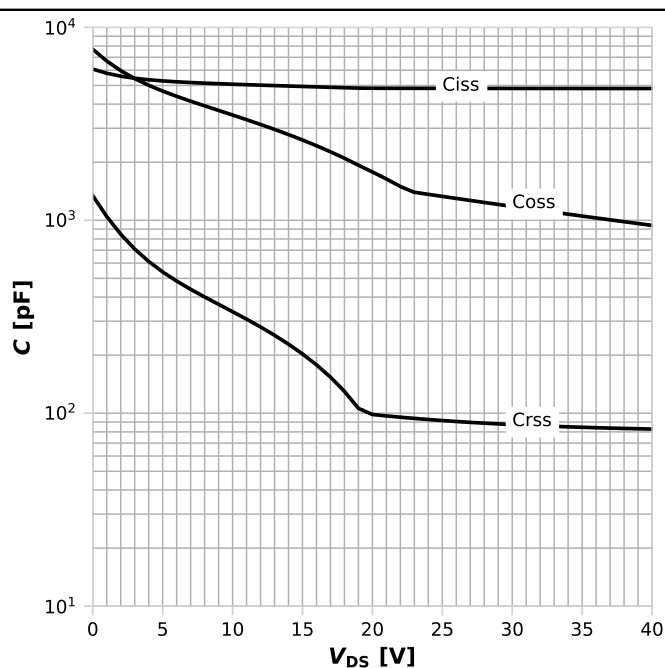
$$R_{DS(on)} = f(T_j), I_D = 70 \text{ A}, V_{GS} = 10 \text{ V}$$

Diagram 10: Typ. gate threshold voltage



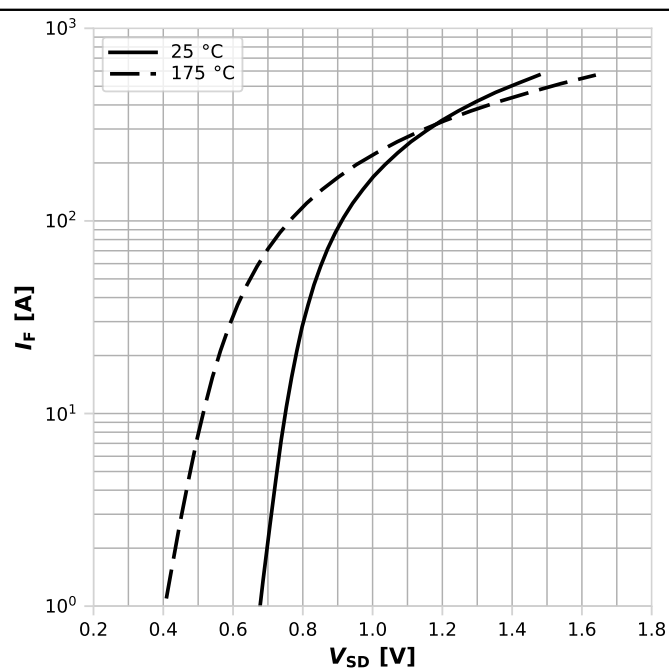
$$V_{GS(th)} = f(T_j), V_{GS} = V_{DS}; \text{ parameter: } I_D$$

Diagram 11: Typ. capacitances



$$C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$$

Diagram 12: Typ. forward characteristics of reverse diode



$$I_F = f(V_{SD}); \text{ parameter: } T_j$$

Diagram 13: Avalanche characteristics

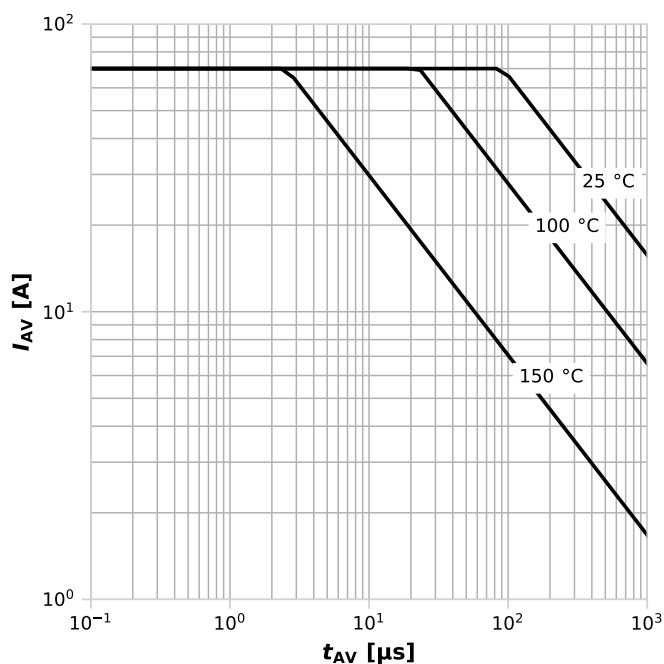

 $I_{AS}=f(t_{AV}); R_{GS}=25\ \Omega; \text{parameter: } T_{j,\text{start}}$ 

Diagram 14: Typ. gate charge

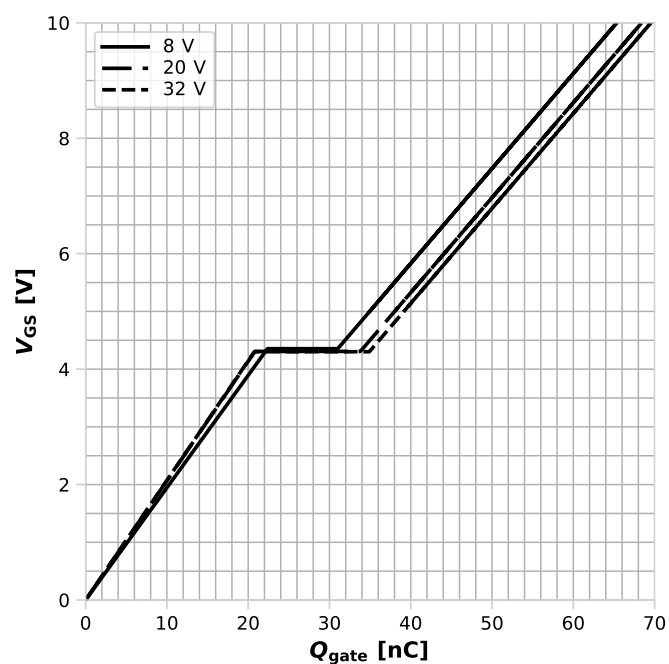
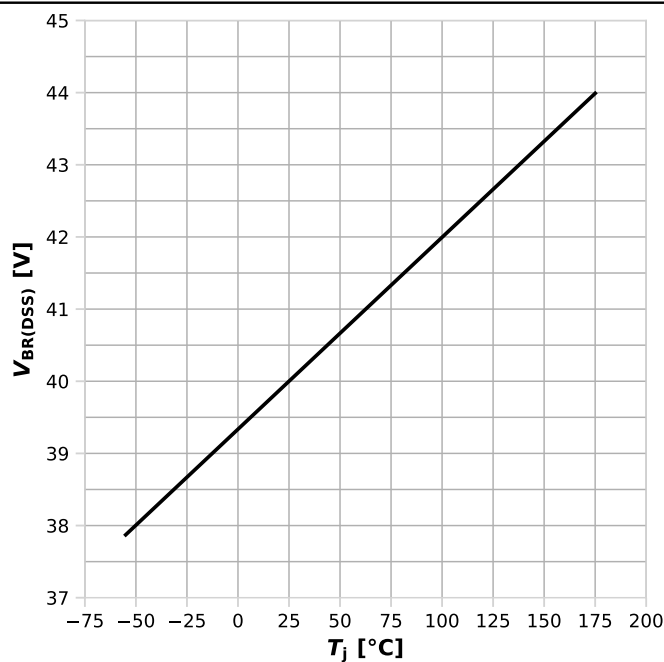
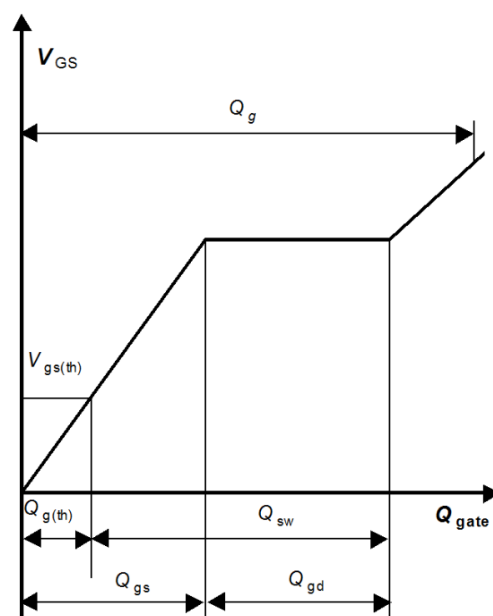

 $V_{GS}=f(Q_{\text{gate}}), I_D=70\ \text{A pulsed}, T_j=25\ ^\circ\text{C}; \text{parameter: } V_{DD}$ 

Diagram 15: Drain-source breakdown voltage

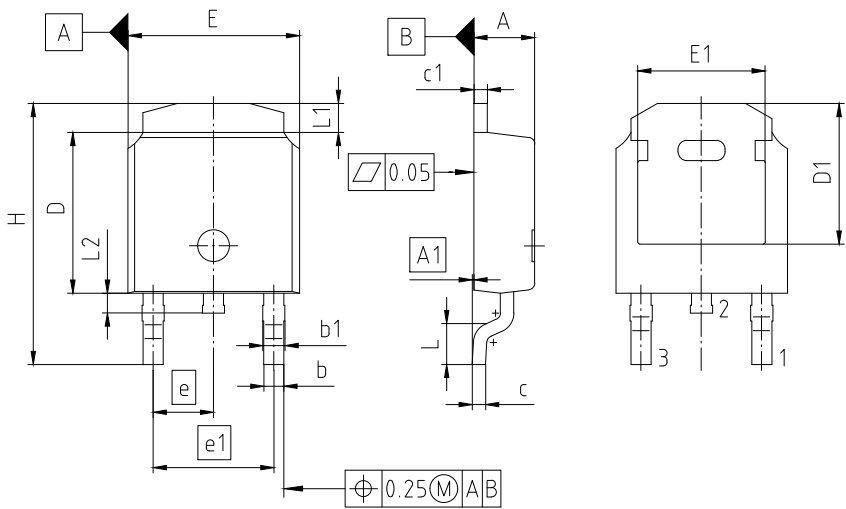

 $V_{BR(DSS)}=f(T_j); I_D=1\ \text{mA}$ 

Gate charge waveforms



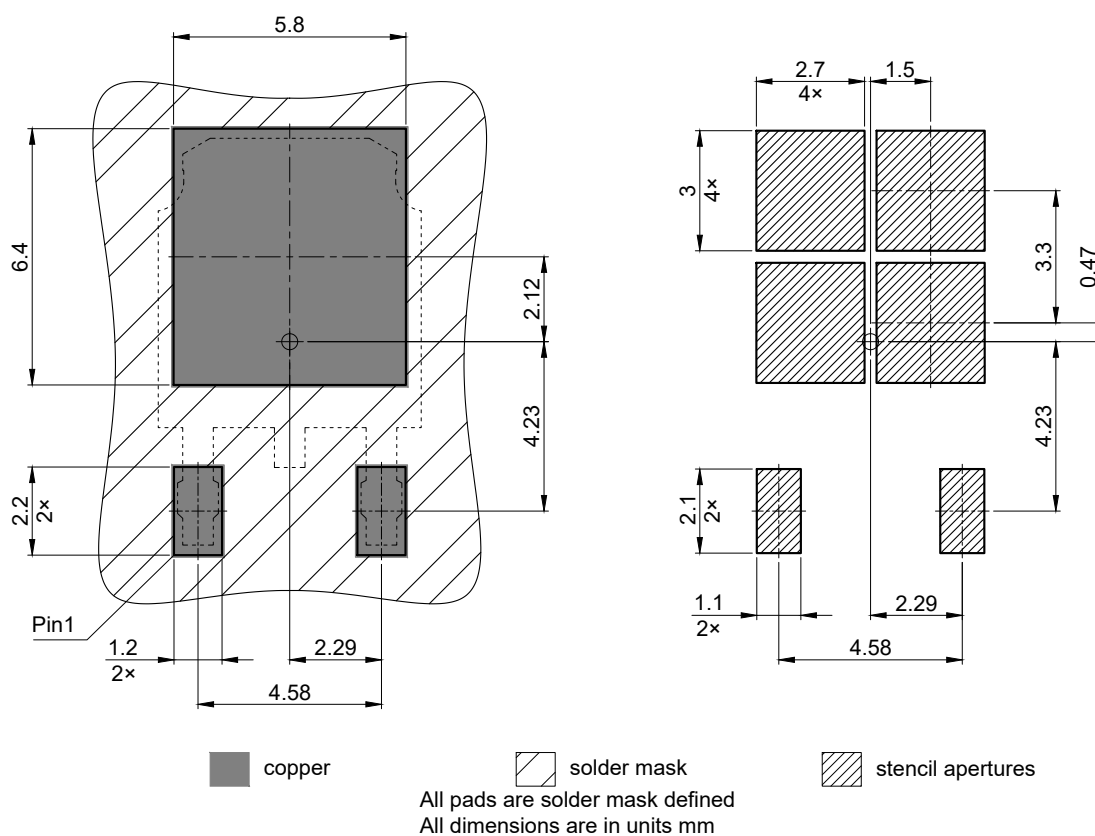
-

5 Package Outlines



PACKAGE - GROUP NUMBER: PG-T0252-3-U01		
DIMENSIONS	MILLIMETERS	
	MIN.	MAX.
A	2.18	2.39
A1	0.00	0.13
b	0.64	0.89
b1	0.76	1.14
c	0.46	0.61
c1	0.40	0.89
D	5.97	6.22
D1	5.21	---
E	6.35	6.73
E1	4.32	---
e	2.29	
e1	4.58	
N	3	
H	9.40	10.41
L	1.40	1.78
L1	0.89	1.27
L2	0.50	1.02

Figure 1 Outline PG-T0252-3, dimensions in mm



**Figure 2 Footprint Drawing PG-T0252-3, dimensions in mm**

## Revision History

IPD023N04NF2S

### Revision 2024-10-14, Rev. 2.2

Previous Revision

Revision	Date	Subjects (major changes since last revision)
2.0	2022-07-13	Release of final version
2.1	2022-09-20	updated Package outline drawing
2.2	2024-10-14	Added trr and Qrr at diF/dt=100 A/μs

### Trademarks

All referenced product or service names and trademarks are the property of their respective owners.

**We Listen to Your Comments** Any information within this document that you feel is wrong, unclear or missing at all? Your feedback will help us to continuously improve the quality of this document. Please send your proposal (including a reference to this document) to: [erratum@infineon.com](mailto:erratum@infineon.com)

### Published by

Infineon Technologies AG

81726 München, Germany

© 2024 Infineon Technologies AG

All Rights Reserved.

### Legal Disclaimer

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics ("Beschaffenheitsgarantie"). With respect to any examples, hints or any typical values stated herein and/or any information regarding the application of the product, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of any third party.

In addition, any information given in this document is subject to customer's compliance with its obligations stated in this document and any applicable legal requirements, norms and standards concerning customer's products and any use of the product of Infineon Technologies in customer's applications.

The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

### Information

For further information on technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies Office ([www.infineon.com](http://www.infineon.com)).

### Warnings

Due to technical requirements, components may contain dangerous substances. For information on the types in question, please contact the nearest Infineon Technologies Office.

The Infineon Technologies component described in this Data Sheet may be used in life-support devices or systems and/or automotive, aviation and aerospace applications or systems only with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support, automotive, aviation and aerospace device or system or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.